

54ACT/74ACT823 9-Bit D Flip-Flop

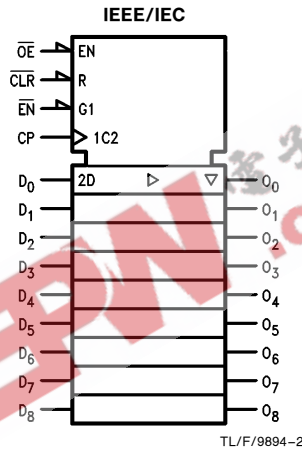
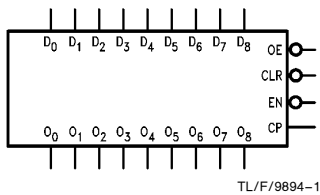
General Description

The 'ACT823 is a 9-bit buffered register. It features Clock Enable and Clear which are ideal for parity bus interfacing in high performance microprogramming systems. The 'ACT823 offers noninverting outputs and is fully compatible with AMD's Am29823.

Features

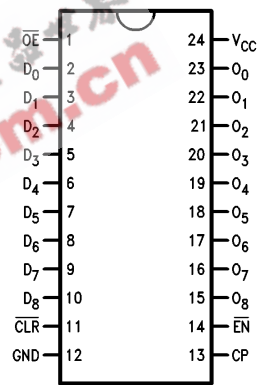
- Outputs source/sink 24 mA
- TRI-STATE® outputs for bus interfacing
- Inputs and outputs are on opposite sides
- 'ACT823 has TTL-compatible inputs

Logic Symbols

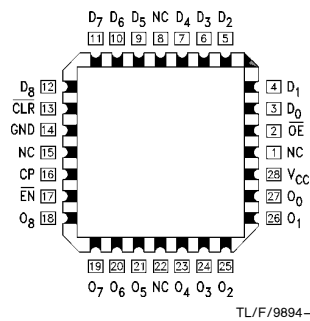


Connection Diagrams

Pin Assignment
for DIP, Flatpak and SOIC



Pin Assignment
for LCC



Pin Names	Description
D ₀ -D ₈	Data Inputs
O ₀ -O ₈	Data Outputs
OE	Output Enable
CLR	Clear
CP	Clock Input
EN	Clock Enable

FACT™ is a trademark of National Semiconductor Corporation.
TRI-STATE® is a registered trademark of National Semiconductor Corporation.

Functional Description

The 'ACT823 consists of nine D-type edge-triggered flip-flops. These have TRI-STATE outputs for bus systems organized with inputs and outputs on opposite sides. The buffered clock (CP) and buffered Output Enable (\overline{OE}) are common to all flip-flops. The flip-flops will store the state of their individual D inputs that meet the setup and hold time requirements on the LOW-to-HIGH CP transition. With \overline{OE} LOW, the contents of the flip-flops are available at the outputs. When \overline{OE} is HIGH, the outputs go to the high impedance state. Operation of the \overline{OE} input does not affect

the state of the flip-flops. In addition to the Clock and Output Enable pins, there are Clear (\overline{CLR}) and Clock Enable (\overline{EN}) pins. These devices are ideal for parity bus interfacing in high performance systems.

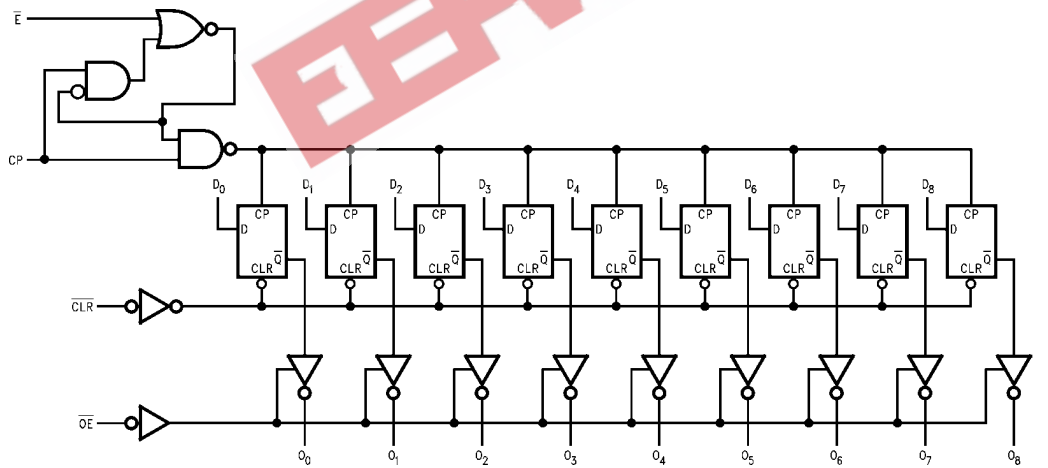
When \overline{CLR} is LOW and \overline{OE} is LOW, the outputs are LOW. When \overline{CLR} is HIGH, data can be entered into the flip-flops. When \overline{EN} is LOW, data on the inputs is transferred to the outputs on the LOW-to-HIGH clock transition. When the \overline{EN} is HIGH, the outputs do not change state, regardless of the data or clock input transitions.

Function Table

Inputs					Internal	Output	Function
\overline{OE}	\overline{CLR}	\overline{EN}	CP	D	Q	O	
H	X	L	↗	L	L	Z	High Z
H	X	L	↗	H	H	Z	High Z
H	L	X	X	X	L	Z	Clear
L	L	X	X	X	L	L	Clear
H	H	H	X	X	NC	Z	Hold
L	H	H	X	X	NC	NC	Hold
H	H	L	↗	L	L	Z	Load
H	H	L	↗	H	H	Z	Load
L	H	L	↗	L	L	L	Load
L	H	L	↗	H	H	H	Load

H = HIGH Voltage Level
 L = LOW Voltage Level
 X = Immaterial
 Z = High Impedance
 ↗ = LOW-to-HIGH Transition
 NC = No Change

Logic Diagram



TL/F/9894-5

Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage (V_{CC})	-0.5V to 7.0V
DC Input Diode Current (I_{IK})	
$V_I = -0.5V$	-20 mA
$V_I = V_{CC} + 0.5V$	+20 mA
DC Input Voltage (V_I)	-0.5V to $V_{CC} + 0.5V$
DC Output Diode Current (I_{OK})	
$V_O = -0.5V$	-20 mA
$V_O = V_{CC} + 0.5V$	+20 mA
DC Output Voltage (V_O)	-0.5V to $V_{CC} + 0.5V$
DC Output Source or Sink Current (I_O)	±50 mA
DC V_{CC} or Ground Current per Output Pin (I_{CC} or I_{GND})	±50 mA
Storage Temperature (T_{STG})	-65°C to +150°C
Junction Temperature (T_J)	
CDIP	175°C
PDIP	140°C

Note 1: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. National does not recommend operation of FACT™ circuits outside databook specifications.

Recommended Operating Conditions

Supply Voltage (V_{CC})	4.5V to 5.5V
*ACT	
Input Voltage (V_I)	0V to V_{CC}
Output Voltage (V_O)	0V to V_{CC}
Operating Temperature (T_A)	
74ACT	-40°C to +85°C
54ACT	-55°C to +125°C
Minimum Input Edge Rate ($\Delta V/\Delta t$)	
*ACT Devices	
V_{IN} from 0.8V to 2.0V	
V_{CC} @ 4.5V, 5.5V	125 mV/ns

DC Electrical Characteristics

Symbol	Parameter	V_{CC} (V)	74ACT		54ACT	74ACT	Units	Conditions
			$T_A = 25^\circ C$		$T_A = -55^\circ C$ to $+125^\circ C$	$T_A = -40^\circ C$ to $+85^\circ C$		
			Typ	Guaranteed Limits				
V_{IH}	Minimum High Level Input Voltage	4.5	1.5	2.0	2.0	2.0	V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$
		5.5	1.5	2.0	2.0	2.0		
V_{IL}	Maximum Low Level Input Voltage	4.5	1.5	0.8	0.8	0.8	V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$
		4.5	1.5	0.8	0.8	0.8		
V_{OH}	Minimum High Level	4.5	4.49	4.4	4.4	4.4	V	$I_{OUT} = -50 \mu A$
			5.49	5.4	5.4	5.4		
		4.5		3.86	3.70	3.76	V	* $V_{IN} = V_{IL}$ or V_{IH} $I_{OH} = -24 mA$ $-24 mA$
V_{OL}	Maximum Low Level Output Voltage	4.5	0.001	0.1	0.1	0.1	V	$I_{OUT} = 50 \mu A$
		5.5	0.001	0.1	0.1	0.1		
		4.5		0.36	0.50	0.44	V	* $V_{IN} = V_{IL}$ or V_{IH} $I_{OL} = 24 mA$ $24 mA$
I_{IN}	Maximum Input Leakage Current	5.5		±0.1	±1.0	±1.0	μA	$V_I = V_{CC}, GND$
I_{OZ}	Maximum TRI-STATE Current	5.5		±0.5	±10.0	±5.0	μA	$V_I = V_{IL}, V_{IH}$ $V_O = V_{CC}, GND$
I_{CCT}	Maximum $I_{CC}/$ Input	5.5	0.6		1.6	1.5	mA	$V_I = V_{CC} - 2.1V$
I_{OLD}	†Minimum Dynamic Output Current	5.5			50	75	mA	$V_{OLD} = 1.65V$ Max
I_{OHD}		5.5			-50	-75	mA	$V_{OHD} = 3.85V$ Min
I_{CC}	Maximum Quiescent Supply Current	5.5		8.0	160	80	μA	$V_{IN} = V_{CC}$ or GND

*All outputs loaded; thresholds on input associated with output under test.

†Maximum test duration 2.0 ms, one output loaded at a time.

Note: I_{CC} limit for 54ACT @ 25°C is identical to 74ACT @ 25°C.

AC Electrical Characteristics

Symbol	Parameter	V _{CC} * (V)	74ACT			54ACT		74ACT		Units
			T _A = +25°C C _L = 50pF			T _A = -55°C to +125°C C _L = 50 pF		T _A = -40°C to +85°C C _L = 50 pF		
			Min	Typ	Max	Min	Max	Min	Max	
f _{max}	Maximum Clock Frequency	5.0	120	158		95		109	MHz	
t _{PLH}	Propagation Delay CP to O _n	5.0	1.5	5.5	9.5	1.5	12.0	1.5	10.5	ns
t _{PHL}	Propagation Delay CP to O _n	5.0	2.0	5.5	9.5	1.5	12.0	1.5	10.5	ns
t _{PHL}	Propagation Delay CLR to O _n	5.0	2.5	8.0	13.5	1.5	18.0	2.0	15.5	ns
t _{pZH}	Output Enable Time OE to O _n	5.0	1.5	6.0	10.5	1.5	11.5	1.5	11.5	ns
t _{pZL}	Output Enable Time OE to O _n	5.0	2.0	6.5	11.0	1.5	12.0	1.5	12.0	ns
t _{PHZ}	Output Disable Time OE to O _n	5.0	1.5	6.5	11.0	1.5	13.5	1.5	12.0	ns
t _{PLZ}	Output Disable Time OE to O _n	5.0	1.5	6.0	10.5	1.5	12.0	1.5	11.5	ns

*Voltage Range 5.0 is 5.0V ±0.5V

AC Operating Requirements

Symbol	Parameter	V _{CC} * (V)	74ACT		54ACT	74ACT	Units
			T _A = +25°C C _L = 50 pF		T _A = -55°C to +125°C C _L = 50 pF	T _A = -40°C to +85°C C _L = 50 pF	
			Typ	Guaranteed Minimum			
t _s	Setup Time, HIGH or LOW D to CP	5.0	0.5	2.5	4.0	2.5	ns
t _h	Hold Time, HIGH or LOW D _n to CP	5.0	0	2.5	3.0	2.5	ns
t _s	Setup Time, HIGH or LOW EN to CP	5.0	0	2.0	4.0	2.5	ns
t _h	Hold Time, HIGH or LOW EN to CP	5.0	0	1.0	3.0	1.0	ns
t _w	CP Pulse Width HIGH or LOW	5.0	2.5	4.5	6.0	5.5	ns
t _w	CLR Pulse Width, LOW	5.0	3.0	5.5	7.0	5.5	ns
t _{rec}	CLR to CP Recovery Time	5.0	1.5	3.5	4.5	4.0	ns

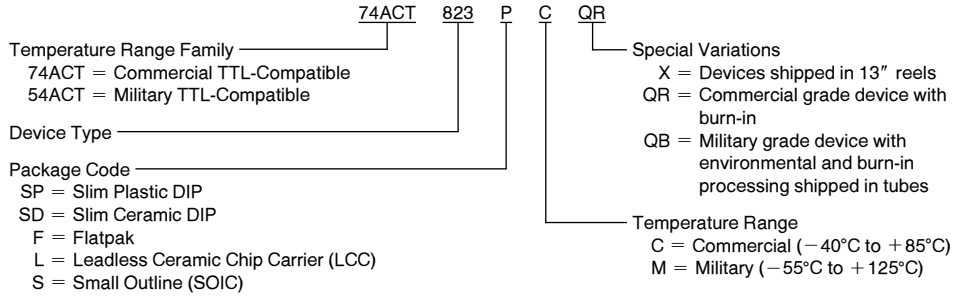
*Voltage Range 5.0 is 5.0V ±0.5V

Capacitance

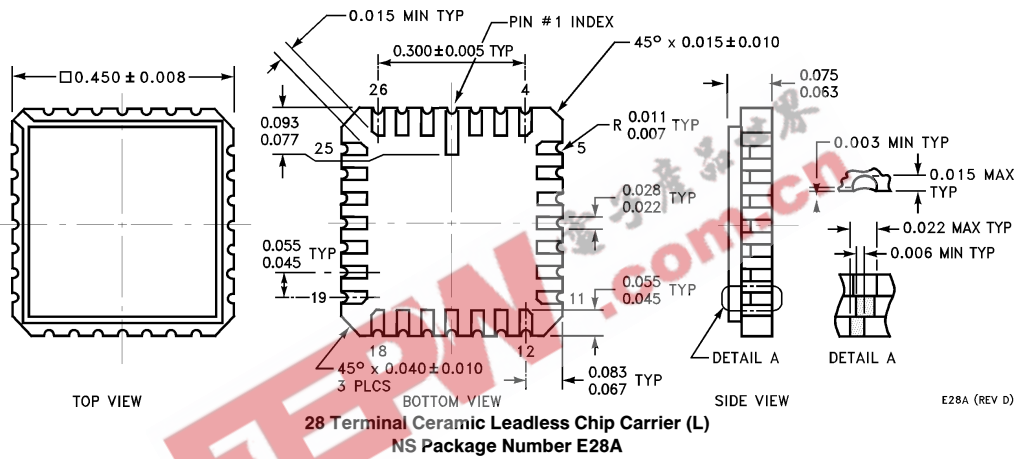
Symbol	Parameter	Typ	Units	Conditions
C _{IN}	Input Capacitance	4.5	pF	V _{CC} = OPEN
C _{PD}	Power Dissipation Capacitance	44	pF	V _{CC} = 5.0V

Ordering Information

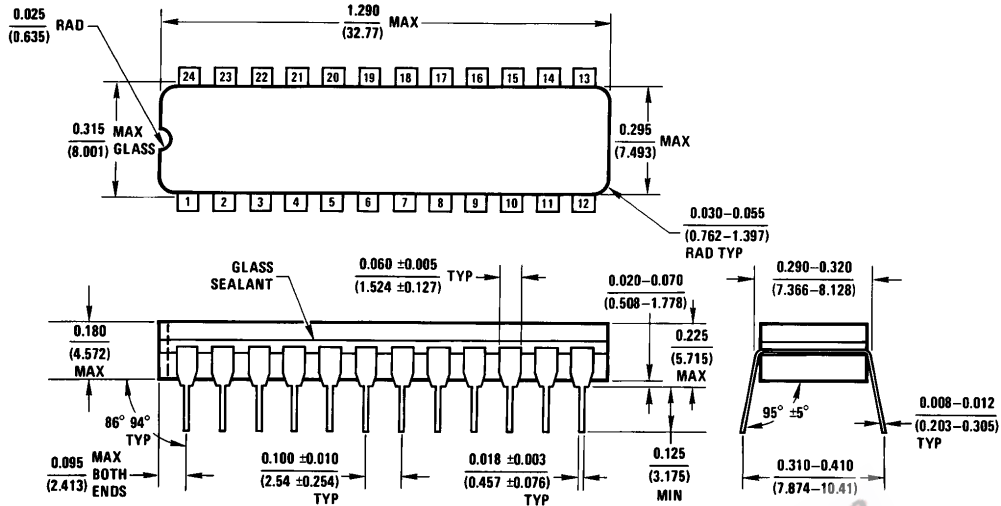
The device number is used to form part of a simplified purchasing code where the package type and temperature range are defined as follows:



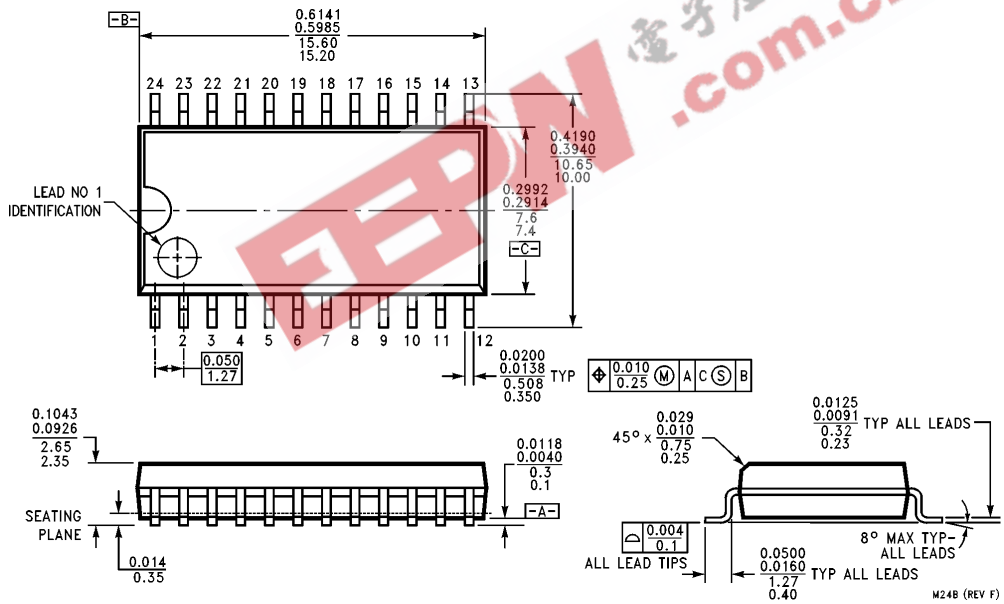
Physical Dimensions inches (millimeters)



Physical Dimensions inches (millimeters) (Continued)

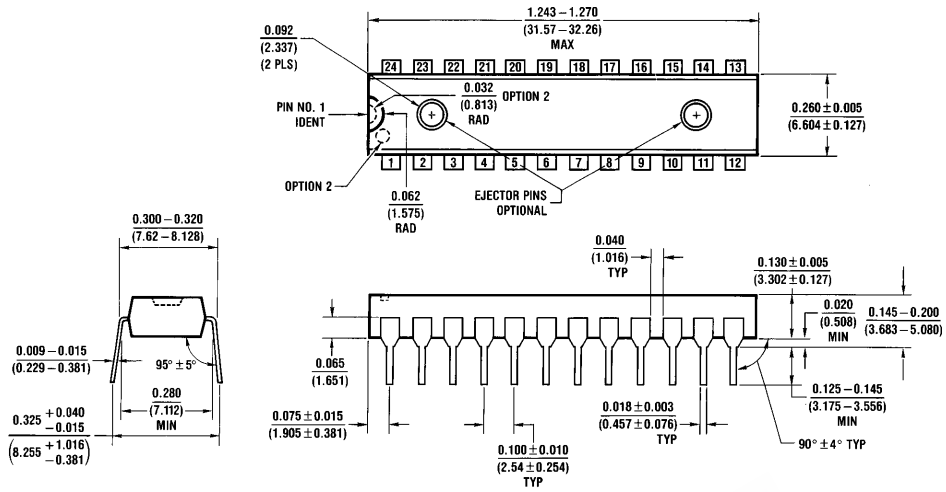


24 Lead Slim (0.300" Wide) Ceramic Dual-In-Line (SD)
NS Package Number J24F



24 Lead Small Outline Integrated Circuit (S)
NS Package Number M24B

Physical Dimensions inches (millimeters) (Continued)



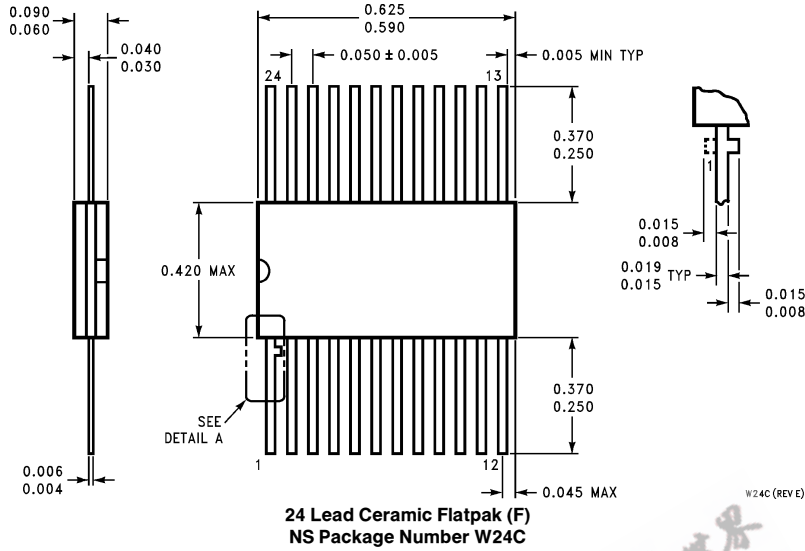
24 Lead Slim (0.300" Wide) Plastic Dual-In-Line (SP)
NS Package Number N24C

N24C (REV F)

EEPW.com.cn 电子产品世界

Physical Dimensions inches (millimeters) (Continued)

Lit. # 114635



LIFE SUPPORT POLICY

NATIONAL'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF NATIONAL SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and whose failure to perform, when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

 <p>National Semiconductor Corporation 2900 Semiconductor Drive P.O. Box 58090 Santa Clara, CA 95052-8090 Tel: 1 (800) 272-9959 TWX: (910) 339-9240</p>	<p>National Semiconductor GmbH Livry-Gargan-Str. 10 D-82256 Fürstenfeldbruck Germany Tel: (81-41) 35-0 Telex: 527649 Fax: (81-41) 35-1</p>	<p>National Semiconductor Japan Ltd. Sumitomo Chemical Engineering Center Bldg. 7F 1-7-1, Nakase, Mihama-Ku Chiba-City, Chiba Prefecture 261 Tel: (043) 299-2300 Fax: (043) 299-2500</p>	<p>National Semiconductor Hong Kong Ltd. 13th Floor, Straight Block, Ocean Centre, 5 Canton Rd. Tsimshatsui, Kowloon Hong Kong Tel: (852) 2737-1600 Fax: (852) 2736-9960</p>	<p>National Semiconductores Do Brazil Ltda. Rue Deputado Lacorda Franco 120-3A Sao Paulo-SP Brazil 05418-000 Tel: (55-11) 212-5066 Telex: 391-1131931 NSBR BR Fax: (55-11) 212-1181</p>	<p>National Semiconductor (Australia) Pty, Ltd. Building 16 Business Park Drive Monash Business Park Nottingham, Melbourne Victoria 3168 Australia Tel: (3) 558-9889 Fax: (3) 558-9898</p>
---	---	---	---	--	---

National does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and National reserves the right at any time without notice to change said circuitry and specifications.